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METHOD AND APPARATUS FOR DETERMINING
PARASITIC CAPACITANCES IN AN INTEGRATED CIRCUIT

## ABSTRACT OF THE DISCLOSURE

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A method of determining a capacitance for use in a circuit simulation is provided. The method may include determining a test structure capacitance of a test structure, simulating a design structure, extracting a design structure capacitance of the simulated design structure, and calculating a parasitic capacitance of the design structure. Calculating the parasitic capacitance may comprise deducting the test structure capacitance from the design structure capacitance.

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